

T3DSO3000HD Data Sheet

Digital Oscilloscope

Debug with Confidence

200 MHz - 1 GHz 12-bit High Resolution



Tools for Improved Debugging

• 12-bit ADC - combined with low noise front end Get better insight on the signal being measured provides excellent noise performance. with minimal noise interference. • Long Capture - up to 400 Mpts/Ch Capture more time and show more waveform detail. • Math and Measure – 9 basic math functions plus FFT Extract results from waveforms and measurements. and 50+ automatic measurement parameters. Built-in web server – supports remote control over Save data for external analysis and screen images LAN port. for reports. History – record function, the maximum recorded Replay the changing waveform history. waveform length is 80,000 frames. Includes Bode Plot and Power Analysis applications Common applications coverage as standard. as standard. • MSO - Optional 16 Digital Channel Probe available. Add mixed signal debugging to your Oscilloscope.

PRODUCT OVERVIEW

T3DSO3024HD 4 Channel 200 MHz 4 Channel 350 MHz T3DS03034HD 4 Channel 500 MHz T3DS03054HD T3DS03104HD 4 Channel 1 GHz

Teledyne Test Tools T3DSO3000HD Digital Oscilloscopes are available in bandwidths of 200 MHz, 350 MHz, 500 MHz and 1 GHz, have maximum record length of 400 Mpts/ch, and display 4 analog channels + optional 16 digital channels mixed signal analysis ability.

The T3DSO3000HD series employs the latest technology which features a maximum waveform capture rate of up to 200,000 wfm/s in normal mode and 890,000 wfm/s in Sequence mode, 256-level intensity grading display function plus a color temperature display mode. It also employs an innovative digital trigger system with high sensitivity and low jitter. The trigger system supports multiple powerful triggering modes including serial bus triggering. Tools such as History waveform recording, Search and Navigate functions, Mask Test, Bode Plot, and Power Analysis allow for extended waveform records captured, stored, and analyzed. An impressive array of measurement and math capabilities, options for a 50 MHz arbitrary waveform generator, as well as serial decoding are also features of the T3DSO3000HD.

The large 10.1" display capacitive touch screen supports multi-touch gestures, with the addition of user-friendly UI design, can greatly improve the operation efficiency. It also supports mouse control, and remote web control over LAN.

Key Features

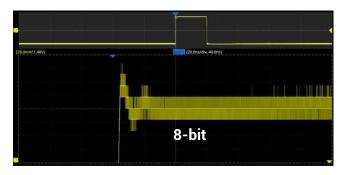
- 12-bit Analog-Digital Convertors with sample rate up to 4 GS/s
- Front ends with 125 µVrms noise floor @ 1 GHz bandwidth and 0.5 % DC gain accuracy
- Four analog channels, up to 1 GHz bandwidth
- Waveform capture rate up to 200,000 wfm/s (normal mode), and 890,000 wfm/s (sequence mode)
- Supports 256-level intensity grading and color temperature display modes
- Up to 400 Mpts/ch record length
- Serial bus triggering and decoder, supports protocols I2C, SPI, UART, CAN, LIN, CAN FD, FlexRay, I2S, MILSTD-1553B, SENT, Manchester and ARINC429
- MSO Optional 16 Digital Channel Logic Probe available
- History waveform record (History) function, the maximum recorded waveform length is 80,000 frames

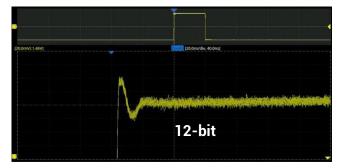
- Automatic measurements on 50+ parameters, supports statistics with histogram, track, trend, Gating measurement, and measurements on Math, History and Ref
- 4 Math traces (4 Mpts FFT, Filter, addition, subtraction, multiplication, division, integration, differential, square root, etc.), supports formula editor
- High Speed hardware-based Average, ERES; High Speed hardware-based Mask Test function, with Mask Editor tool for creating user-defined masks
- Optional 50 MHz waveform generator
- Interfaces include: 2x USB 3.0 Host, 1x USB 2.0 Host, USB 3.0 Device (USBTMC), 1000M LAN ((VXI-11/ Telnet/Socket/LXI)), External Trigger In, Aux Out (Pass/Fail, Trigger Out)
- Built-in web server supports remote control over the LAN port using a web browser. Supports SCPI remote control commands. Supports external mouse and keyboard

Models and Key Specification

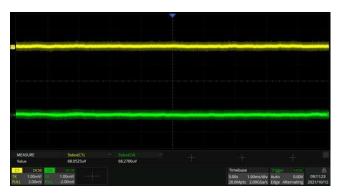
Model	T3DS03024HD	T3DS03034HD	T3DS03054HD	T3DS03104HD
Analog channels	4 + EXT			
Bandwidth	200 MHz	350 MHz	500 MHz	1 GHz (800 MHz in non-interleaving mode)
Sample rate (Max.)	4 GS/s (interleaving mod	le), 2 GS/s (non-interleav	ing mode)	
Memory depth (Max.)	400 Mpts/ch (interleavin 100 Mpts/ch (non-interle		200 Mpts/ch (interleaving	g mode: dual-channel),
Waveform capture rate (Max.)	Normal mode: 200,00 Sequence mode: 890,00	0 wfm/s; 0 wfm/s		
Vertical resolution	12-bit. Up to 16-bit in EF	ES mode		
Trigger type	Edge, Slope, Pulse width Setup/hold, Delay, Serial	, Window, Runt, Interval, [Propout, Pattern, Video, Qu	ualified, Nth edge,
Serial trigger and decode	I ² C, SPI, UART, CAN, LIN, CAN FD, FlexRay, I ² S, MIL-STD-1553B, SENT, Manchester (decode only), ARINC429			
Measurement	50+ parameters, statistic	cs, histogram, trend, and	track supported	
Math	4 traces 4 Mpts FFT, +, -, x, ÷, ∫dt, d/dt, √, Identity, Negation, Absolute, Sign, ex, 10x, In, Ig, Interpolation, MaxHold, MinHold, ERES, Average, Filter. Supports formula editor			
Data analysis	Search, Navigate, History, Mask Test, Digital Voltmeter, Counter, Waveform Histogram, Bode plot, and Power Analysis			
Digital channel (optional)	16-channel; maximum sample rate up to 1 GS/s; record length up to 100 Mpts			
USB AWG module (optional)	One channel, 50 MHz, sample rate of 125 MHz, wavelength of 16 kpts, isolated output			
1/0	USB 3.0 Host x2, USB 2.0 Host x1, USB 3.0 Device, 10M/100M/1000M LAN, External trigger, Auxiliary output (TRIG OUT, PASS/FAIL)			
Probe	Four 500 MHz passive probes			
Display	10.1 TFT-LCD with capacitive touch screen (1024*600)			

12-bit High Resolution

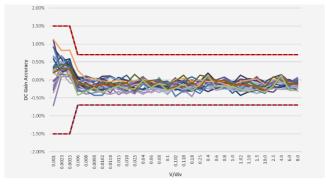




12-bit resolution shows you more details and less noise on the waveform.



Low noise floor: Only 125 µVrms at 1 GHz bandwidth



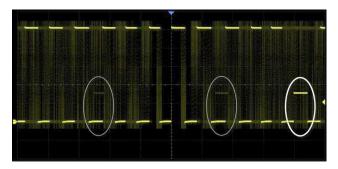
0.5 % DC gain accuracy



Excellent User Interface and User Experience

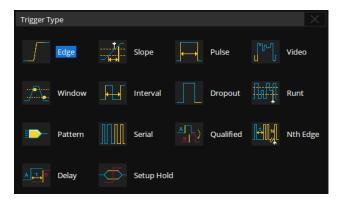
- 10.1" display with 1024 x 600 resolution
- Capacitive touch screen, supporting multi-touch gestures, can move or scale the waveform traces quickly by fingertouch movements, which greatly improves the operation efficiency
- Built-in WebServer supports remote control on a web page over LAN
- Supports external mouse and keyboard

High Waveform Update Rate



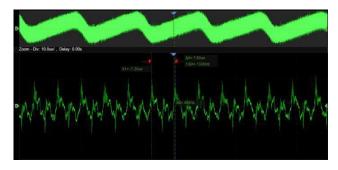
With a waveform update rate of up to 200,000 wfm/s, the oscilloscope can easily capture unusual or low probability events. In Sequence mode, the waveform capture rate can reach 890,000 wfm/s.

Multiple Trigger Functions



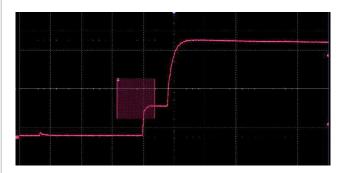
Edge, Slope, Pulse, Video, Windows, Runt, Interval, Dropout, Pattern, Qualified, Nth edge, Setup/hold, Delay, and serial trigger.

Deep Record Length



Using hardware-based Zoom technique and record length of up to 400 Mpts, users can select a slower timebase without compromising the sample rate, and then quickly zoom in to focus on the area of interest.

Trigger Zone



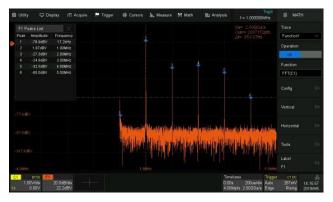
Trigger Zone is available for advanced triggering. Combine spatial triggering with common trigger mode to isolate signals of interest.

Advanced Math Function



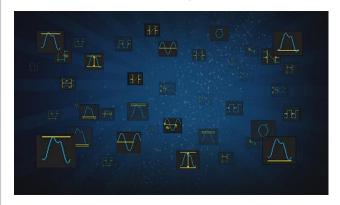
In addition to the traditional (+, -, X, /) operations, FFT, integration, differential, square root, and more are supported. Formula Editor is available for more complex operations. 4 math traces are available.

Deep Memory FFT



Hardware-accelerated FFT supports up to 4 Mpts operation. This provides high-frequency resolution with a fast refresh rate. The FFT function also supports a variety of window functions so that it can adapt to different spectrum measurement needs. Three modes (Normal, Average, and Max hold) can satisfy different requirements for observing the power spectrum. Auto peak detection and markers are supported.

Measurements of a Variety of Parameters



Parameter measurements include 4 categories: horizontal, vertical, miscellaneous, and CH delay providing a total of 50+ different types of measurements. Measurements can be performed within a specified gate period. Measurements on Math, Reference, and History frames are supported.

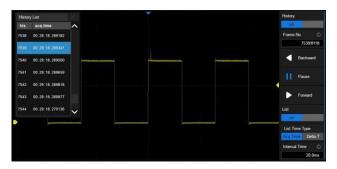
Parameter Statistics Function



Statistics show the current value, maximum value, minimum value, standard deviation, and mean value of up to 12 parameters simultaneously. A histogram is available to show the probability distribution of a parameter. Trend and Track are available to show the parameter value vs. time.

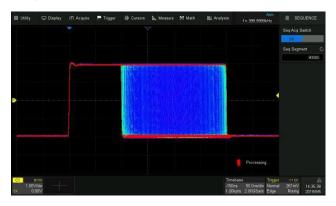
For horizontal parameters such as period, all results are extracted from a frame, instead of just calculating the first one. This accelerates statistics on horizontal measurements much more and enables distribution observation in a frame using Histogram and Track.

History Mode



History function can record up to 80,000 frames of waveforms. The recording is executed automatically so that the customer can playback the history waveforms at any time to observe unusual events and quickly locate the area of interest using the cursors or measurements. The failed frames of the Mask Test can be stored as history.

Sequence Mode



Segmented memory collection will store the waveform into multiple memory segments (up to 80,000) and each segment will store a triggered waveform as well the dead time information. The interval between segments can be as small as 2 µs. All of the segments can be played back using the History function.

Search and Navigate



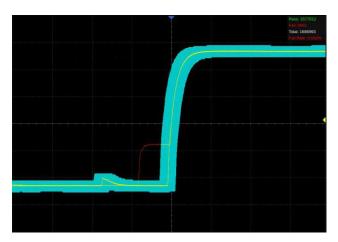
The oscilloscope can search events specified by the user in a frame. Events flagged by the Search can be recalled automatically using Navigate. It can also navigate by time (delay position) and history frames.

Serial Bus Decode

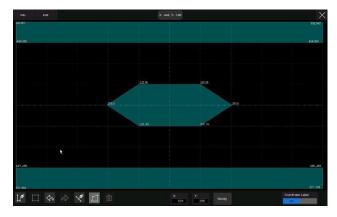


Display the decoded characters through the events list. Bus protocol information can be quickly and intuitively displayed in tabular form. I²C, SPI, UART, CAN, LIN, CAN FD, FlexRay, I2S, MIL-STD-1553B, SENT, and Manchester are supported.

Hardware-based High-Speed Mask Test Function



The oscilloscope utilizes a hardware-based Mask Test function, performing up to 28,000 Pass/Fail decisions each second. It is easy to generate user-defined test templates to provide trace mask comparisons, making it suitable for long-term signal monitoring or automated production line testing.



Built-in Mask Editor application helps to create custom masks.

Bode Plot



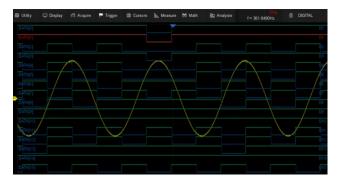
The oscilloscope can control the built-in waveform generator or a stand-alone Teledyne Test Tool generator, to scan the amplitude and phase-frequency response of the DUT, and display the data as a Bode Plot. This makes it possible to replace expensive network analyzers in some applications.

Power Analysis



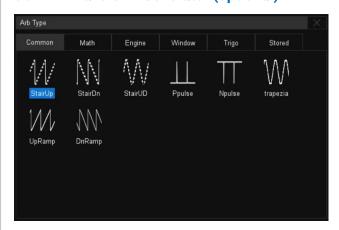
The Power Analysis option provides a full suite of power measurements and analysis, which greatly improve the measurement efficiency in switching power supplies and power devices design.

Digital Channels (T3DSO2000-LS)



Four analog channels plus 16 digital channels enable users to acquire and trigger the waveforms then analyze the pattern, simultaneously with one instrument.

50 MHz Waveform Generator (optional)



The 50 MHz waveform generator can output waveforms with up to 50 MHz frequency and ±3 V amplitude. Six basic waveforms plus multiple types of arbitrary waveforms are built-in.



1x USB 2.0 Host, USB 3.0 Device (USBTMC), 1000M LAN ((VXI-11/Telnet/Socket/LXI)), External Triger In, Aux Out (Pass/Fail, Trigger Out)

All specifications are not guaranteed unless the following conditions are met:

- The oscilloscope calibration period is current
- The oscilloscope has been working continuously for at least 30 minutes at the specified temperature (18 °C ~ 28 °C)

Acquire (analog)

Sample rate	4 GS/s (interleaving mode ¹⁾ , 2 GS/s (non-interleaving mode ²⁾)
Memory depth ^{3) 4)}	400 Mpts/ch (interleaving mode, single-channel), 200 Mpts/ch (interleaving mode, dual-channel), 100 Mpts/ch (non-interleaving mode)
Memory management mode	Auto, Fixed sample rate, Fixed memory length
Waveform update rate	Normal mode: up to 200,000 wfm/s Sequence mode: up to 890,000 wfm/s
Intensity grading	256-level
Peak detect	0.5 ns
Average	4, 16, 32, 64, 128, 256, 512, 1024, 2048, 4096, 8192
ERES	Enhanced bit: 0.5, 1, 1.5, 2, 2.5, 3, 3.5, 4 bits
Sequence	Up to 80,000 segments, interval between triggers = 1.12 μs min.
History	Up to 80,000 frames
Interpolation	sinx/x, x

Model	T3DS03024HD	T3DS03034HD	T3DS03054HD	T3DS03104HD
Vertical (analog)				
Channel	4 + EXT			
Bandwidth (-3 dB) @ 50 Ω	200 MHz	350 MHz	500 MHz	Interleaving mode: 1 GHz Non-interleaving mode: 800 MHz
Rise time @ 50 Ω (typical)	1.7 ns	830 ps	610 ps	Interleaving mode: 450 ps Non-interleaving mode: 570 ps
Bandwidth (-3 dB) @ 1 MΩ	200 MHz	350 MHz	500 MHz	500 MHz
Bandwidth limit	Hardware Bandwid 20 MHz: 20 MHz 200 MHz: 200 MHz	(±20 %)		
Resolution	12-bit			
ENOB ⁵⁾ (typical)	8.7-bit	8.5-bit	8.4-bit	8.2-bit
Noise floor ⁶⁾ (rms, @ 50 Ω, typical, 1 mV/div)	56 μV	70 μV	90 μV	125 μV
Range	8 divisions			

 $_{5)}\,$ 50 Ω input impedance, 50 mV/div, 4 GS/s, 24.9943 MHz/-1 dBFS input

Interleaving mode: only one of C1/C2 and/or only one of C3/C4 activated
 Non-interleaving mode: both C1/C2 and/or both C3/C4 activated
 In Average and ERES modes, the memory depth is 20 Mpts/ch (interleaving mode), 10 Mpts/ch (non-interleaving mode)
 single-channel: only one channel is active; dual-channel: one of C1/C2 and one of C3/C4 activated

⁶⁾ Use the Stdev (also known as ACrms) measurement

Model	T3DS03024HD	T3DS03034HD	T3DS03054HD	T3DS03104HD
Vertical scale (probe 1X)	50 Ω: 0.5 mV/div – 1	V/div O V/div O V/div (Zoom mode)		
DC gain accuracy	0.5 mV/div ~ 4.95 mV, 5 mV/div ~ 10 V/div: ±	/div: ±1.5 %; :0.5 % typical, ±1.0 % ma	ximum	
Offset accuracy	± (1 % of the offset set	ting + 0.5 % of full scale	+ 0.02 % maximum offs	et + 1 mV)
Offset range (probe 1X)	1 MΩ: 0.5 mV/div ~ 5 mV/d 5.1 mV/div ~ 10 mV/ 10.2 mV/div ~ 20 mV/ 20.5 mV/div ~ 100 mV 102 mV/div ~ 200 mV 205 mV/div ~ 1 V/div 1.02 V/div ~ 10 V/di	div: ±4 V; div: ±8 V; //div: ±16 V; //div: ±80 V; : ±160 V;	50 Ω: 0.5 mV/div ~ 5 mV/di 5.1 mV/div ~ 10 mV/di 10.2 mV/div ~ 20 mV/di 20.5 mV/div ~ 1 V/div:	div: ±4 V; div: ±8 V;
Low frequency response (AC coupling -3 dB)	6 Hz (typical)			
Overshoot (100 mV/div, 150 ps edge @ 50 Ω, typical)	3 %	7 %	10 %	18 %
Coupling	DC, AC, GND			
Impedance	1 MΩ: (1 MΩ ±2 %) (1 50 Ω: 50 Ω ±1 %	5 pF ±3 pF)		
Max. input voltage	1 M Ω \leq 400 Vpk (DC + 50 Ω \leq 5 Vrms	AC), DC ~ 10 kHz		
SFDR	≥ 45 dBc			
CH to CH Isolation (@ 50 Ω)	60 dB up to 200 MHz	60 dB up to 200 MHz 50 dB up to 350 MHz	60 dB up to 200 MHz 50 dB up to 500 MHz	60 dB up to 200 MHz 50 dB up to 500 MHz 40 dB up to 1 GHz
Probe Attenuation	1X, 10X, 100X, custom	l		
Horizontal				
Time scale	1 ns/div - 1000 s/div	1 ns/div - 1000 s/div	500 ps/div – 1000s/div	200 ps/div - 1000s/div
Range	10 divisions			
Display mode	Y-T, X-Y, Roll			
Roll mode	≥ 50 ms/div			
Skew (C1 ~ C4)	< 100 ps			
Time base Accuracy	±2 ppm initial (0 ~ 50°	C); ±0.5 ppm 1st year a	ging; ±3 ppm 20-year ag	ging

Trigger

Mode	Auto, Normal, Single				
Level	Internal: ±4.1 div from the center of the screen EXT: ± 0.61 V EXT/5: ± 3.05 V				
Ext Trigger input voltage	1 M Ω ≤ 42 Vpk 50 Ω ≤ 5 Vrms				
Hold off range	By time: $8 \text{ ns} \sim 30 \text{ s} (8 \text{ ns step})$ By event: $1 \sim 10^8$				
Coupling	C1 ~ C4 DC: Passes all components of the s AC: Blocks DC components and att LFRJ: Attenuates the frequency components and att HFRJ: Attenuates the frequency components RJ: Increases the trigger hysteresis EXT DC: Passes all components of the s AC: Blocks DC components and att LFRJ: Attenuates the frequency components and att LFRJ: Attenuates the frequency components and attenuates attenuates the frequency components and attenuates the frequency components are considered to the frequency components and attenuates the frequency components are considered to the frequency comp	tenuates signals below 15 Hz conents below 2.4 MHz conents above 1.3 MHz s signal tenuates signals below 18 Hz conents below 7.5 kHz			
Accuracy (typical)	C1 ~ C4: ±0.2 div EXT: ±0.3 div				
Sensitivity	CH1 ~ CH4: >10 mV/div: 5 mV/div ~ 10 mV/div: ≤ 2 mV/div:	Noise RJ = OFF ±0.26 div ±0.26 div ±0.5 div	Noise RJ = ON ±0.33 div ±0.33 div ±0.5 div		
	EXT: 200 mVpp, DC ~ 10 MHz 300 mVpp, 10 MHz ~ bandwidth (300 MHz)				
	EXT/5: 1 Vpp, DC ~ 10 MHz 1.5 Vpp, 10 MHz ~ bandwid	th (300 MHz)			
Jitter	C1 ~ C4: < 10 ps rms (typical), ≥ 6 div Vpp < 200 ps rms	o sine, 2.5 mV/div ~ 10 V/div E	XT:		
Displacement	Pre-Trigger: 0 ~ 100 % memory Delay-Trigger: 0 ~ 10,000 div				
Zone	Up to 2 zones Source: C1~C4 Property: Intersect, Not Intersect				
Edge Trigger					
Source	C1 ~ C4 / EXT / (EXT/5) / AC Line / D0 ~	D15			
Slope	Rising, Falling, Rising & Falling				
Slope Trigger					
Source	C1 ~ C4				
Slope	Rising, Falling				
Limit range	<, >, in range, out of range				
Time range	2 ns ~ 20 s, Resolution = 1 ns				
Pulse Width Trigger					
Source	C1 ~ C4 / D0 ~ D15				
Polarity	+width, -width				
Limit range	<, >, in range, out of range				
Limitarige	2 ns ~ 20 s, Resolution = 1 ns				

Video Trigger	
Source	C1 ~ C4
Standard	NTSC, PAL, 720p/50, 720p/60, 1080p/50, 1080p/60, 1080i/50, 1080i/60, Custom
Synchronization	Any, Select
Trigger Condition	Line, Field
Window Trigger	
Source	C1 ~ C4
Window type	Absolute, Relative
Interval Trigger	
Source	C1 ~ C4 / D0 ~ D15
Slope	Rising, Falling
Limit range	<, >, in range, out of range
Time range	2 ns ~ 20 s, Resolution = 1 ns
Dropout Trigger	
Source	C1 ~ C4 / D0 ~ D15
Timeout type	Edge, State
Slope	Rising, Falling
Time range	2 ns ~ 20 s, Resolution = 1 ns
Runt Trigger	
Source	C1 ~ C4
Polarity	Positive, Negative
Limit range	<, >, in range, out of range
Time range	2 ns ~ 20 s, Resolution = 1 ns
Pattern Trigger	
Source	C1 ~ C4 / D0 ~ D15
Pattern Setting	Don't Care, Low, High
Logic	AND, OR, NAND, NOR
Limit range	<, >, in range, out of range
Time range	2 ns ~ 20 s, Resolution = 1 ns
Qualified Trigger	
Туре	State, State with Delay, Edge, Edge with Delay
Qualified Source	C1 ~ C4 / D0 ~ D15
Edge Trigger Source	C1 ~ C4 / D0 ~ D15
Nth Edge Trigger	
Source	C1 ~ C4 / D0 ~ D15
Slope	Rising, Falling
Idle time	8 ns ~ 20 s, Resolution = 1 ns
Edge Number	1 ~ 65535
Delay Trigger	
Source A	C1 ~ C4 / D0 ~ D15
Source B	C1 ~ C4 / D0 ~ D15
Slope	Rising, Falling
Limit range	<, >, in range, out of range
Time range	2 ns ~ 20 s, Resolution = 1 ns

Serial Trigger	
Source	C1 ~ C4 / D0 ~ D15
Protocol	I ² C, SPI, UART, CAN, LIN, CAN FD, FlexRay, I ² S, MIL-STD-1553B, SENT, ARINC429
I ² C	Type: Start, Stop, Restart, No Ack, EEPROM, Address & Data, Data Length
SPI	Type: Data
UART	Type: Start, Stop, Data, Parity Error
CAN	Type: All, Remote, ID, ID+Data, Error
LIN	Type: Break, Frame ID, ID+Data, Error
CAN FD	Type: Start, Remote, ID, ID+Data, Error
FlexRay	Type: TSS, Frame, Symbol, Errors
l ² S	Type: Data, Mute, Clip, Glitch, Rising Edge, Falling Edge
MIL-STD-1553B	Type: Transfer, Word, Error, Timing
SENT	Type: Start, Slow channel, Fast channel, Error
ARINC429	Type: Word Start, Word End, Label, Label + Data, Error, Any Bit, Any Bit of 0, Any Bit of 1
Serial Decoder	
Decoders	2
Threshold	-4.1 ~ 4.1 div
List	1 ~ 7 lines
Decoder type	Full duplex
I ² C	
Source	C1 ~ C4 / D0 ~ D15
Signal	SCL, SDA
Address	7-bit, 10-bit
SPI	
Source	C1 ~ C4 / D0 ~ D15
Signal	CLK, MISO, MOSI, CS
Edge Select	Rising, Falling
Chip select	Active high, Active low, Clock timeout
Bit Order	LSB, MSB
UART	
Source	C1 ~ C4 / D0 ~ D15
Signal	RX, TX
Data Width	5-bit, 6-bit, 7-bit, 8-bit
Parity Check	None, Odd, Even, Mark, Space
Stop Bit	1-bit, 1.5-bit, 2-bit
Idle Level	Low, High
Bit Order	LSB, MSB
CAN	
Source	C1 ~ C4 / D0 ~ D15
LIN	
LIN Version	Ver 1.3, Ver 2.0
Source	C1 ~ C4 / D0 ~ D15
	COO has 1000 has 0400 has 4000 has 10000 has 0 outside

Baud Rate

600 bps, 1200 bps, 2400 bps, 4800 bps, 9600 bps, 19200 bps, Custom

CAN FD	
Source	C1 ~ C4 / D0 ~ D15
Nominal Baud Rate	10 kbps, 25 kbps, 50 kbps, 100 kbps, 250 kbps, 1 Mbps, Custom
Data Baud Rate	500 kbps, 1 Mbps, 2 Mbps, 5 Mbps, 8 Mbps, 10 Mbps, Custom
FlexRay	
Source	C1 ~ C4 / D0 ~ D15
Baud Rate	2.5 Mbps, 5 Mbps, 10 Mbps, Custom
I ² S	
Source	C1 ~ C4 / D0 ~ D15
Signal	BCLK, WS, DATA
Audio Variant	Audio-I ² S, Audio-LJ, Audio-RJ
Start Bits	0~31
Data Bits	1 ~ 32
MIL-STD-1553B	1 02
Source	C1 ~ C4
SENT	
Source	C1 ~ C4 / D0 ~ D15
Manchester	01 01/20 210
Source	C1 ~ C4
Baud Rate	500 bps ~ 5 Mbps
ARINC429	000 bps - 0 (vibps
Source	C1 ~ C4
Baud Rate	12.5 kbps ~ 100 kbps, tolerance 1 % ~ 20 %
Word format	L/SDI/D/SSM, L/D/SSM, L/D
- Void format	L/301/0/331VI, L/0/331VI, L/0
Math	
Trace	F1 ~ F4
Source	C1 ~ C4, M1 ~ M4, F1 ~ F4, Zoom traces
Operation	FFT, +, -, x, ÷, ∫dt, d/dt, √, Identity, Negation, x , Sign, ex, 10x, ln, lg, Interpolation, Max hold, Min hold, ERES, Average, Filter, Formula Editor
FFT	Length: 4 Mpts, 2 Mpts, 1 Mpts, 512 kpts, 256 kpts, 128 kpts, 64 kpts, 32 kpts, 16 kpts, 8 kpts, 4 kpts, 2 kpts
	Window: Rectangular, Blackman, Hanning, Hamming, Flattop
	Display: Full Screen, Split, Exclusive Mode: Normal, Max hold, Average
	Tools: Peaks, Markers
Analysis	
Search	
Source	C1 ~ C4, History
Mode	Edge, Slope, Pulse, Interval, Runt
Copy setting	Copy from trigger, Copy to trigger
Navigate	
Туре	Search event, Time, History frame
Mask Test	
Source	C1 ~ C4, Z1 ~ Z4
Source Mask creating	C1 ~ C4, Z1 ~ Z4 Auto (Create mask), Customized (Mask Editor)

DVM	
Source	C1 ~ C4
Mode	DC mean, DC RMS, AC RMS, Peak-peak, Amplitude
Plot	Bar, Histogram, Trend
Gate	20 ms
Bode Plot	
Source	C1 ~ C4
Supported signal sources	SAG1021I (Connection: USB), SDG series waveform generators (Connection: USB, LAN)
Sweep type	Simple, Vari-level
Frequency	Mode: Linear, Logarithmic Range: 10 Hz ~ 120 MHz
Measure	Upper cutoff frequency, Lower cutoff frequency, Bandwidth, Gain margin, Phase margin
Power Analysis	
Measure	Power quality, Current Harmonics, Inrush current, Switching loss, Slew rate, Modulation, Output ripple, Turn on/turn off, Transient response, PSRR, Efficiency, SOA
Histogram	
Source	C1 ~ C4
Type	Horizontal, Vertical, Both
Counter	
Source	C1 ~ C4
Frequency resolution	7 digits
Totalizer	Counter on edges, supports Gate and Trigger

Digital Channels (optional)

Max. Sampling Rate	1 GS/s
Memory Depth	100 Mpts/ch
Min. Detectable Pulse Width	3.3 ns
Level Group	D0 ~ D7, D8 ~ D15
Level Range	-10 V ~ 10 V
Logic Type	TTL, CMOS, LVCMOS3.3, LVCMOS2.5, Custom
Skew	D0 ~ D15: ±1 sampling interval Digital to Analog: ± (1 sampling interval +1 ns)

USB AWG Module (optional)

1
50 MHz
125 MS/s
1 μHz
±50 ppm
14 bit
-1.5 V \sim +1.5 V (into 50 Ω) -3 V \sim +3 V (into High-Z)
Sine, Square, Ramp, Pulse, DC, Noise, 45 Arbitrary
50 Ω ± 2 %
Over voltage protection, Current limit
±42 Vpk

Sine	
Frequency	1 μHz ~ 50 MHz
Offset accuracy (10 kHz)	±(1% * offset setting value +3 mVpp)
Amplitude flatness	± 0.3 dB, compare to 10 kHz, 2.5 Vpp into 50 Ω
SFDR	DC ~ 1 MHz -60 dBc 1 MHz ~ 5 MHz -55 dBc 5 MHz ~ 25 MHz -50 dBc
Harmonic distortion	DC ~ 5 MHz -50 dBc 5 MHz ~ 25 MHz -45 dBc
Square/Pulse	
Frequency	1 μHz ~ 10 MHz
Duty cycle	1%~99%
Edge	< 24 ns (10 % ~ 90 %)
Overshoot	< 3 % (typical, 1 kHz, 1 Vpp)
Pulse width	> 50 ns
Jitter (cycle-cycle)	< 500 ps + 10 ppm
Ramp	
Frequency	1 μHz ~ 300 kHz
Linearity	< 0.1% of Pk-Pk (typical, 1 kHz, 1 Vpp, 50 % symmetry)
Channels	0 % ~ 100 %
DC	
Offset range	±1.5 V (into 50 Ω)
Accuracy	±3 V (into Hi-Z)
Noise	
Bandwidth (-3 dB)	>50 MHz
Arbitrary Wave	
Frequency	1 μHz ~ 5 MHz
Waveform memory	16 kpts
Sample rate	125 MS/s
Wave import	From EasyWaveX, from U-disk, directly from waveform data of analog channels
1/0	
Front	USB 3.0 Host x2, Calibration Signal: 1 kHz, 3 V Square
Rear	USB 2.0 Host, USB 3.0 Device, LAN: 10/100/1000M (RJ45), External Trigger, EXT: ≤1.5 Vrms, EXT/5: ≤ 7.5 Vrms, Auxiliary Output: TRIG OUT(3.3 V LVCMOS), PASS/FAIL OUT(3.3 V TTL)
Display	
Display Type	10.1 TFT LCD with capacitive touch screen
Resolution	1024 × 600
Contrast (typical)	500:1
Backlight (typical)	500 nit

Display Setting

Diopidy octains							
Range	8 x 10 grid						
Display Type	Dot, Vector						
Persistence Time	OFF, 0.1 s, 0.2 s, 0.5 s, 1 s, 5 s, 10	s, 30 s, infinite					
Color Display	Normal, Color; Supports custome	er trace color					
Language	Simplified Chinese, Traditional Cl Italian, Portuguese	ninese, English, French, Japanese, G	German, Spanish, Russian,				
Built-in Help System	Simplified Chinese, English						
Environmental							
Temperature	Operating: $0 ^{\circ}\text{C} \sim 50 ^{\circ}\text{C}$ Non-operating: $-30 ^{\circ}\text{C} \sim 70 ^{\circ}\text{C}$						
Humidity	Operating: 5 % \sim 90 % RH up to 30 °C, derates linearly to 50 % RH at 50 °C Non-operating: 5 % \sim 95 %						
Altitude	Operating: ≤ 3,000 m, 25 °C Non-operating: ≤15,000 m						
Electromagnetic Compatibility	EN IEC 61326-2-1:2021 (Basic)	U), meets or exceeds EN IEC 61326	-1:2021,				
	Conducted disturbance	CISPR 11/EN 55011	CLASS A group 1 150 kHz – 30 MHz				
	Radiated disturbance	CISPR 11/EN 55011	CLASS A group 1 30 MHz – 1 GHz				
	Electrostatic discharge (ESD)	IEC 61000-4-2/EN 61000-4-2	4.0 kV (Contact), 8.0 kV (Air)				
	Radio-frequency electromagnetic field Immunity	IEC 61000-4-3/EN 61000-4-3	10 V/m (80 MHz to 1 GHz); 3 V/m (1.4 GHz to 2 GHz); 1 V/m (2.0 GHz to 2.7 GHz)				
	Electrical fast transients (EFT)	IEC 61000-4-4/EN 61000-4-4	2 kV (Input AC Power Ports)				
	Surges	IEC 61000-4-5/EN 61000-4-5	1 kV (Line to line) 2 kV (Line to ground)				
	Radio-frequency continuous conducted Immunity	IEC 61000-4-6/EN 61000-4-6	3 V, 0.15 – 80 MHz				
	Voltage dips and interruptions	IEC 61000-4-11/EN 61000-4-11	Voltage Dips: 0 % UT during 1 cycle; 40 % UT during 10/12 cycles; 70 % UT during 25/30 cycles Voltage interruptions: 0 % UT during 250/300 cycles				
Safety	TUV Certified. Conforms to: UL 61010-1:2012/R: 2018-11; UL 61010-2-030:2018 CAN/CSA-C22.2 No. 61010-1:2012/A1:2018-11; CAN/CSA-C22.2 No. 61010-2-030:2018 Meets Low Voltage Directive (2014/35/EU). Conforms to: EN 61010-1:2010+A1:2019; EN IEC 61010-2-030:2021						
RoHS	EU 2015/863						
Power Supply							
Input Voltage & Frequency	100 ~ 240 Vrms 50/60 Hz						
Power consumption	120 W max., 80 W typical, 4 W typical in standby mode						
Mechanical							
Dimensions	Length × Height × Width = 317.2 mm × 236.0 mm × 149.0 mm (including knobs and supporting legs)						
Weight	Net Weight 4.1 kg, Gross Weight 5.6 kg						

All T3DSO3000HD Series Oscilloscopes come with a 3 year Teledyne LeCroy warranty.



ORDERING INFORMATION

T3DSO3000HD Series Probes

Probe type	Model	Picture	Description		
Passive	PP026-1	6	500 MHz bandwidth, 10 M Ω , 10X Probe, 1 supplied per channel. Replacement probe for the T3DS3000HD Series Oscilloscope.		
Logic Probe	T3DS02000-LS	0	Optional 16 Channel Logic Probe.		
USB AWG Module	T3DSO-FGMOD	TO DOES	Output Sine, Square, Ramp, pulse, Noise, DC and 45 built-in waveforms. The arbitrary waveforms can be accessed and edited by the EasyScope PC software		
Rackmount	T3DSOHD-RACK		The rackmount occupies a height of 5U. Support the oscilloscope for rack installation.		
Soft Case	WS4KHD-SOFTCASE		Oscilloscope Soft Carrying Case.		

Ordering information

Description	12-bit, 200 MHz, 4 GS/s, 4-CH, 400 Mpts/ch memory depth, 10.1" capacitive touch screen	T3DSO3024HD
	12-bit, 350 MHz, 4 GS/s, 4-CH, 400 Mpts/ch memory depth, 10.1" capacitive touch screen	T3DS03034HD
	12-bit, 500 MHz, 4 GS/s, 4-CH, 400 Mpts/ch memory depth, 10.1" capacitive touch screen	T3DSO3054HD
	12-bit, 1 GHz, 4 GS/s, 4-CH, 400 Mpts/ch memory depth, 10.1" capacitive touch screen	T3DS03104HD
Standard Accessories	Passive Probe x 4	
	USB Cable	
	Power Cord	
	Wireless mouse	
	Quick Start Guide	
	Certificate of Calibration	
Optional Accessories	16 Channel MSO Probe	T3DSO2000-LS
	500 MHz Passive Probe, 10:1, 10 MΩ	PP026-1
	USB AWG Module	T3DSO-FGMOD
	Rackmount	T3DSOHD-RACK
	Soft Case	WS4KHD-SOFTCASE

ABOUT TELEDYNE TEST TOOLS



Company Profile

Teledyne LeCroy is a leading provider of oscilloscopes, protocol analyzers and related test and measurement solutions that enable companies across a wide range of industries to design and test electronic devices of all types. Since our founding in 1964, we have focused on creating products that improve productivity by helping engineers resolve design issues faster and more effectively. Oscilloscopes are tools used by designers and engineers to measure and analyze complex electronic signals in order to develop high-performance systems and to validate electronic designs in order to improve time to market.

The Teledyne Test Tools brand extends the Teledyne LeCroy product portfolio with a comprehensive range of test equipment solutions. This new range of products delivers a broad range of quality test solutions that enable engineers to rapidly validate product and design and reduce time-to-market. Designers, engineers and educators rely on Teledyne Test Tools solutions to meet their most challenging needs for testing, education and electronics validation.

Location and Facilities

Headquartered in Chestnut Ridge, New York, Teledyne Test Tools and Teledyne LeCroy has sales, service and development subsidiaries in the US and throughout Europe and Asia. Teledyne Test Tools and Teledyne LeCroy products are employed across a wide variety of industries, including semiconductor, computer, consumer electronics, education, military/aerospace, automotive/industrial, and telecommunications.

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